

**Search Notes**

Application/Control No.

10/613,216

Examiner

Duc Nguyen

Applicant(s)/Patent under  
Reexamination

TOYOSHIMA ET AL.

Art Unit

2643

**SEARCHED**

Class	Subclass	Date	Examiner
Updated	search	2/4/2006	DN
same	as		
all	previous		
	searches		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR